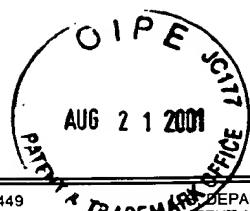


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 210131US0PCT		SERIAL NO. 09/857,214	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Hayao TANAKA			
		FILING DATE		GROUP		1772	
		June 22, 2001					
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
WBA	AA	4 472 357	09/18/84	Didya D. LEVY et al.	422	102	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO	0 137 292	04/17/85	EP	YES		No
	AP	00-033472	02/06/96	JP	YES		No
WBA	AQ	1 401 233	07/16/75	GB	YES		No
	AR				YES		
	AS				YES		
	AT				YES		
	AU				YES		
	AV				YES		
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW					RECEIVED MAR 9 2002 1000	
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner	<i>Mark B. Schubay</i>				Date Considered 08/07/02		

\*Examiner: Initial if reference is considered whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

Form PTO 1449 (Modified)		DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 210131US0PCT	SERIAL NO. 09/857,214	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Hayao TANAKA				
		FILING DATE June 22, 2001	GROUP 1772			
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
	AA					
	AB					
	AC					
	AD					
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	AH					
	AI					
	AJ					
	AK					
	AL					
	AM					
	AN					
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
WBA	AO	60-91983	05/23/85	JAPAN (with English Abstract)		X
	AP	4-19561	01/23/92	JAPAN		X
	AQ	10-114800	05/06/98	JAPAN		X
	AR	6-174726	06/24/94	JAPAN (with English Abstract)		X
↓	AS	7-128336	05/19/95	JAPAN (with English Abstract)		X
	AT					
	AU					
	AV					
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)						
	AW					
	AX					
	AY					
	AZ					
Examiner <i>Mark Blaylock</i>		Date Considered 08/07/02				

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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